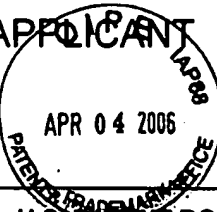


GROUP 2879

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LIST OF ART CITED BY APPLICANT

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 ATTY. DOCKET NO.
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Hun Gun PARK et al.

 FILING DATE
December 24, 2003

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2879

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
CR	6,348,762	2/2002	Nunomura et al.	313	582	—
CR	6,424,095	7/2002	Hirao et al.	315	169.4	—
CR	6,452,333	9/2002	Torisaki et al.	313	586	—
CR	6,838,825	1/2005	Shiiki et al.	313	582	—

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CR	2002/0063524	5/2002	Nakamura et al.	313	582	—
CR	2004/0070340	4/2004	Araki et al.	313	582	—
CR	2004/0135507	7/2004	Park et al.	313	582	—

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	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
CR	JP 2001-325887	11/22/2001	Japan (full text w/ English abstract)			X	
CR	JP 2002-324488	11/8/2002	Japan (full text w/ English abstract)			X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

EXAMINER

Elizabeth Buckley

DATE CONSIDERED

21 April 2006

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